

<b>Notice of References Cited</b>	Application/Control No. 10/624,511	Applicant(s)/Patent Under Reexamination CEREDA ET AL.	
	Examiner Feben M. Haile	Art Unit 2616	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0179052	09-2003	Sawdey et al.	333/135
*	B	US-6,472,951	10-2002	Fiedziuszek et al.	333/126
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	K	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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